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Application/Control No.	Applicant(s)/Patent un Reexamination	ider
10/779,561	LI ET AL.	
Examiner	Art Unit	
Andrew Y. Chou	2192	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PALM inventor name search	5/30/2007	AYC
EAST Text search	6/1/2007	AYC
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